

<b>Notice of References Cited</b>	Application/Control No. 10/595,310		Applicant(s)/Patent Under Reexamination YAMASHITA ET AL.	
	Examiner SING P. CHAN		Art Unit 1791	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-4,934,791	06-1990	Shimizu et al.	349/107
*	B	US-6,057,961	05-2000	Allen et al.	359/494
*	C	US-5,096,520	03-1992	Faris, Sades M.	156/99
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	English translation of JP 53-31971
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.